

Notice of References Cited	Application/Control No. 10/698,328		Applicant(s)/Patent Under Reexamination CLARK, EDWARD ALAN	
	Examiner Kyung Hye Shin		Art Unit 2443	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,958,016 A	09-1999	Chang et al.	709/229
*	B	US-5,966,662 A	10-1999	Murto, Juhani	455/458
*	C	US-6,081,592 A	06-2000	Battle, Calvin W.	379/309
*	D	US-2001/0009014 A1	07-2001	Savage et al.	709/204
*	E	US-2002/0080822 A1	06-2002	Brown et al.	370/475
*	F	US-2002/0080949 A1	06-2002	Mikhailov et al.	379/230
*	G	US-2004/0015405 A1	01-2004	Cloutier et al.	705/26
*	H	US-7,221,753 B2	05-2007	Hutton et al.	379/265.11
*	I	US-7,257,110 B2	08-2007	Laxman et al.	370/352
*	J	US-7,372,957 B2	05-2008	Strathmeyer et al.	379/265.01
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.